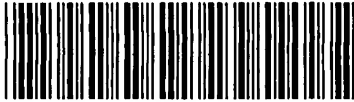


Search Notes

Application/Control No.

10/001,849

Examiner

X. L. Bautista

Applicant(s)/Patent under
Reexamination

HULL ET AL.

Art Unit

2179

SEARCHED

Class	Subclass	Date	Examiner
715	700,716	4/20/2007	XB
	717,719		
	727,733		
	764,835		
	838,839		
	855		
715	500,501.1		
	512,513		
	526,527		
358	1.1		
	1.15		
	1.18		
	530		
	540		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	716,719	4/20/2007	XB
715	501.1,512		
358	1.1		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	4/20/2007	XB
Databases searched: US-PGPUB; EPO; JPO; DERWENT; IBM_TDB		
Interf. Search History		
IEEE Search		
Google Search		